

Search Notes

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10/666,097

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

GAN ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	129	9/12/2005	NKV
330	134	9/12/2005	NKV
330	136	9/12/2005	NKV
330	124R	3/30/2006	NKV
330	295	3/30/2006	NKV
330	278	3/30/2006	NKV
330	279	3/30/2006	NKV

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Search History Printout		3/30/2006	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	3/30/2006	NKV